

Search Notes

Application/Control No.

10/730,017

Examiner

Julian Mercado

Applicant(s)/Patent under
Reexamination

IWASE ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
considered parent files	9/10/05	